

August 1999 Revised October 1999

74ACT533 Octal Transparent Latch with 3-STATE Outputs

General Description

The ACT533 consists of eight latches with 3-STATE outputs for bus organized system applications. The flip-flops appear transparent to the data when Latch Enable (LE) is HIGH. When LE is low, the data satisfying the input timing requirements is latched. Data appears on the bus when the Output Enable (OE) is LOW. When OE is HIGH, the bus output is in the high impedance state.

Features

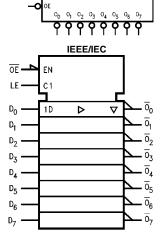
- \blacksquare I_{CC} and I_{OZ} reduced by 50%
- Eight latches in a single package
- 3-STATE outputs drive bus lines or buffer memory address registers
- Outputs source/sink 24 mA
- Inverted version of the ACT373
- TTL-compatible inputs

Ordering Code:

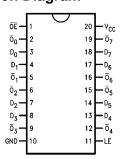
Order Number	Package Number	Package Description
74ACT533SC	M20B	20-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300" Wide Body
74ACT533MTC	MTC20	20-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide
74ACT533PC N20A 20-Lead Plas		20-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide

Device also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering code

Logic Symbols



Connection Diagram



Pin Descriptions

Pin Names	Description
D ₀ –D ₇	Data Inputs
LE	Latch Enable Input
ŌĒ	Output Enable Input
\overline{O}_0 – \overline{O}_7	3-STATE Latch Outputs

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Functional Description

The ACT533 contains eight D-type latches with 3-STATE standard outputs. When the Latch Enable (LE) input is HIGH, data on the D_n inputs enters the latches. In this condition the latches are transparent, i.e., a latch output will change state each time its D input changes. When LE is LOW, the latches store the information that was present on the D inputs at setup time preceding the HIGH-to-LOW transition of LE. The 3-STATE standard outputs are controlled by the Output Enable (\overline{OE}) input. When \overline{OE} is \underline{LOW} , the standard outputs are in the 2-state mode. When $\overline{\text{OE}}$ is HIGH, the standard outputs are in the high impedance mode but this does not interfere with entering new data into

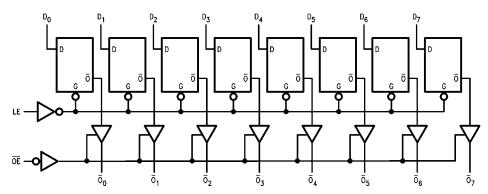
Truth Table

	Inputs					
LE	OE	D _n	Ōn			
Х	Н	Х	Z			
Н	L	L	Н			
Н	L	Н	L			
L	L	Х	\overline{O}_0			

H = HIGH Voltage Level

 $\frac{Z = Ingramp States}{\overline{O}_0} = \frac{Z}{\overline{O}_0} = \frac{$

Logic Diagram



Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

L = LOW Voltage Level

Z = High Impedance

Absolute Maximum Ratings(Note 1)

Supply Voltage (V_{CC}) -0.5V to +7.0V

DC Input Diode Current (I_{IK})

$$\begin{split} V_I = & -0.5 V & -20 \text{ mA} \\ V_I = & V_{CC} + 0.5 V & +20 \text{ mA} \end{split} \label{eq:viscosity}$$

-0.5V to $V_{CC} + 0.5V$

DC Output Diode Current (I_{OK})

DC Input Voltage (V_I)

$$\begin{split} \text{V}_{\text{O}} &= -0.5 \text{V} & -20 \text{ mA} \\ \text{V}_{\text{O}} &= \text{V}_{\text{CC}} + 0.5 \text{V} & +20 \text{ mA} \end{split}$$

DC Output Voltage (V_O) -0.5V to $V_{CC} + 0.5V$

DC Output Source

or Sink Current (I_O) \pm 50 mA

DC V_{CC} or Ground Current

per Output Pin (I_{CC} or I_{GND}) \pm 50 mA

Storage Temperature (T_{STG}) $-65^{\circ}C$ to $+150^{\circ}C$

DC Latchup Source

or Sink Current \pm 300 mA

Junction Temperature (T_J)

PDIP 140°C

Recommended Operating Conditions

Minimum Input Edge Rate $\Delta V/\Delta t$

V_{IN} from 0.8V to 2.0V

V_{CC} @ 4.5V, 5.5V 125 mV/ns

Note 1: Absolute maximum ratings are those values beyond which damage to the device may occur. The databook specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature, and output/input loading variables. Fairchild does not recommend operation of FACTnu circuits outside databook specifications.

DC Electrical Characteristics

Symbol	Parameter	V _{CC}	T _A = +25°C		$T_A = -40^{\circ}C \text{ to } +85^{\circ}C$	Units	Conditions	
Syllibol	rarameter	(V)	Тур С		aranteed Limits	Ullis		
V _{IH}	Minimum HIGH Level	4.5	1.5	2.0	2.0	V	V _{OUT} = 0.1V	
	Input Voltage	5.5	1.5	2.0	2.0	V	or V _{CC} – 0.1V	
V _{IL}	Maximum LOW Level	4.5	1.5	0.8	0.8	V	V _{OUT} = 0.1V	
	Input Voltage	5.5	1.5	8.0	0.8	V	or V _{CC} – 0.1V	
V _{OH}	Minimum HIGH Level	4.5	4.49	4.4	4.4	V	I - 50 A	
	Output Voltage	5.5	5.49	5.4	5.4	V	$I_{OUT} = -50 \mu A$	
							$V_{IN} = V_{IL} \text{ or } V_{IH}$	
		4.5		3.86	3.76	V	$I_{OH} = -24 \text{ mA}$	
		5.5		4.86	4.76		$I_{OH} = -24 \text{ mA (Note 2)}$	
V _{OL}	Maximum LOW Level	4.5	0.001	0.1	0.1	V	Ι _{ΟΙΙΤ} = 50 μΑ	
	Output Voltage	5.5	0.001	0.1	0.1	v	1007 = 30 μΑ	
							$V_{IN} = V_{IL} \text{ or } V_{IH}$	
		4.5		0.36	0.44	V	I _{OL} = 24 mA	
		5.5		0.36	0.44		I _{OL} = 24 mA (Note 2)	
I _{IN}	Maximum Input	5.5		±0.1	±1.0	μА	$V_1 = V_{CC}$, GND	
	Leakage Current	0.0		±0.1	±1.0	μΑ	vi = vCC, GIAD	
I _{OZ}	Maximum 3-STATE	5.5		±0.25	±2.5	μА	$V_I = V_{IL}, V_{IH}$	
	Leakage Current	0.0		_0.20	±2.0	μοι	$V_O = V_{CC}$, GND	
I _{CCT}	Maximum	5.5	0.6		1.5	mA	$V_1 = V_{CC} - 2.1V$	
	I _{CC} /Input	0.0	0.0		1.5	IIIA	v1 = vCC - 2.1v	
I _{OLD}	Minimum Dynamic	5.5			75	mA	V _{OLD} = 1.65V Max	
I _{OHD}	Output Current (Note 3)	5.5			-75	mA	V _{OHD} = 3.85V Min	
I _{CC}	Maximum Quiescent	5.5		4.0	40.0	μА	$V_{IN} = V_{CC}$	
	Supply Current	0.0		4.0	40.0	μΛ	or GND	

Note 2: All outputs loaded; thresholds on input associated with output under test.

Note 3: Maximum test duration 2.0 ms, one output loaded at a time.

AC Electrical Characteristics

Symbol Parameter		V _{CC} (V)	$T_A = +25^{\circ}C$ $C_L = 50 \text{ pF}$		$T_A = -40$ °C to $+85$ °C $C_L = 50$ pF		Units	
		(Note 4)	Min	Тур	Max	Min	Max	
t _{PHL}	Propagation Delay	5.0	2.0	6.0	8.0	2.0	8.5	ns
t _{PLH}	D _n to O _n	3.0	2.0	0.0	0.0	2.0	0.5	110
t _{PHL}	Propagation Delay	5.0	2.5	7.0	9.0	2.5	9.5	ns
t _{PLH}	LE to O _n	3.0	2.5	7.0	3.0	2.0	3.3	113
t _{PZL} , t _{PZH}	Output Enable Time	5.0	2.0	7.0	9.0	2.0	9.5	ns
t _{PHZ} , t _{PLZ}	Output Disable Time	5.0	1.0	8.0	10.0	1.0	10.5	ns

Note 4: Voltage Range 5.0 is $5.0V \pm 0.5V$.

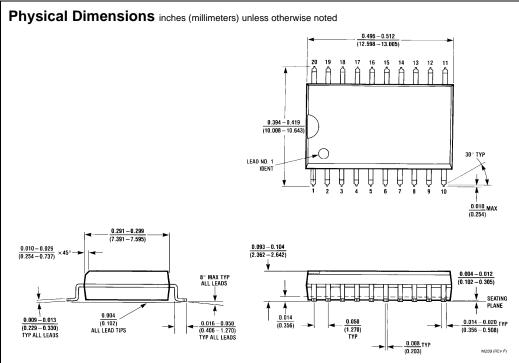
AC Operating Requirements

Symbol	Parameter	V _{CC} (V)	$T_A = +25^{\circ}C$ $C_L = 50 \text{ pF}$		$T_A = -40$ °C to $+85$ °C $C_L = 50$ pF	Units	
		(Note 5)	Тур	Guara	nteed Minimum		
t _S	Setup Time, HIGH or LOW D _n to LE	5.0	0	3.0	3.0	ns	
t _H	Hold Time, HIGH or LOW D _n to LE	5.0	0	1.5	1.5	ns	
t _W	LE Pulse Width, HIGH	5.0	2.0	4.0	4.0	ns	

Note 5: Voltage Range 5.0 is $5.0V \pm 0.5V$.

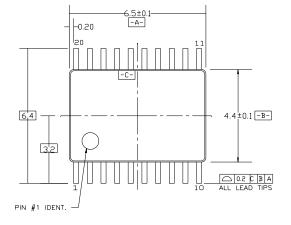
Capacitance

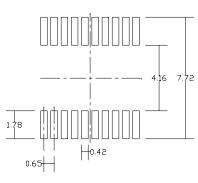
Symbol	Parameter	Тур	Units	Conditions
C _{IN} Input Capacitance		4.5	pF	V _{CC} = OPEN
C _{PD}	Power Dissipation Capacitance	40	pF	V _{CC} = 5.0V



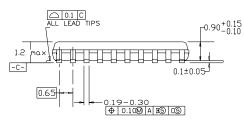
20-Lead Small Outline Integrated Circuit, JEDEC MS-013, 0.300" Wide Body Package Number M20B

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)





LAND PATTERN RECOMMENDATION

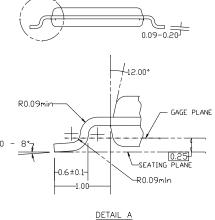


DIMENSIONS ARE IN MILLIMETERS

NOTES:

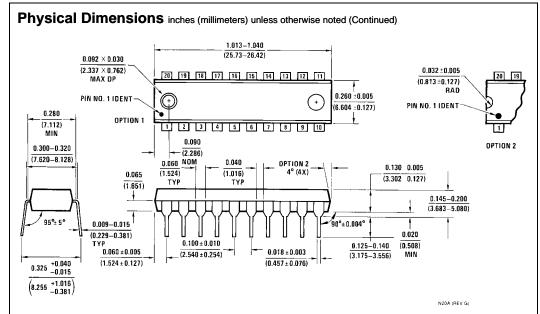
- A. CONFORMS TO JEDEC REGISTRATION MID-153, VARIATION AC, REF NOTE 6, DATE $7/93.\,$
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLDS FLASH, AND TIE BAR EXTRUSIONS.
- D. DIMENSIONS AND TOLERANCES PER ANSI Y14.5M, 1982.

MTC20REVD1



SEE DETAIL A

20-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide Package Number MTC20



20-Lead Plastic Dual-In-Line Package, JEDEC MS-001, 0.300" Wide Package Number N20A

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